

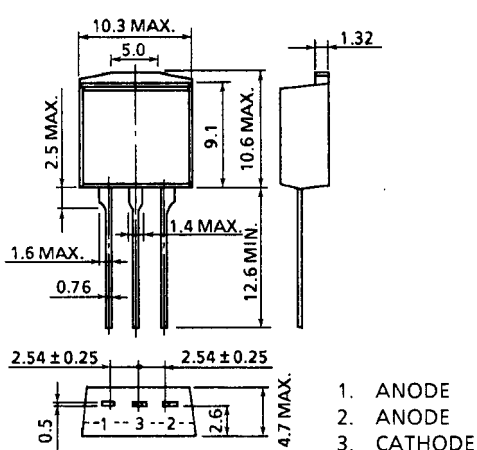
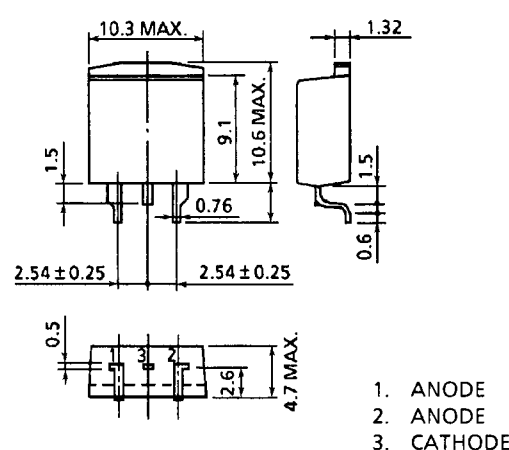
TOSHIBA HIGH EFFICIENCY DIODE STACK (HED) SILICON EPITAXIAL TYPE

20DL2C48A,U20DL2C48A,20FL2C48A,U20FL2C48A

SWITCHING MODE POWER SUPPLY APPLICATION
CONVERTER & CHOPPER APPLICATION

- Repetitive Peak Reverse Voltage : $V_{RRM}=200, 300V$
- Average Output Rectified Current : $I_O=20A$
- Ultra Fast Reverse-Recovery Time : $t_{rr}=35ns$ Max.
- Low Switching Losses and Output Noise.

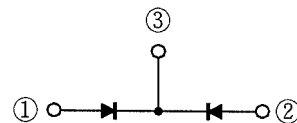
Unit in mm

20DL2C48A,20FL2C48A,		U20DL2C48A,U20FL2C48A	
 1. ANODE 2. ANODE 3. CATHODE		 1. ANODE 2. ANODE 3. CATHODE	
JEDEC	—	JEDEC	—
EIAJ	—	EIAJ	—
TOSHIBA	12-10D1A	TOSHIBA	12-10D2A

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
Repetitive Peak Reverse Voltage	20DL2C48A	VRRM	200	V
	U20DL2C48A			
	20FL2C48A			
	U20FL2C48A			
Average Output Rectified Current		IO	20	A
Peak One Cycle Surge Forward Current		IFSM	100 (50Hz)	A
			110 (60Hz)	
Junction Temperature		Tj	−40~150	°C
Storage Temperature Range		Tstg	−40~150	°C

POLARITY

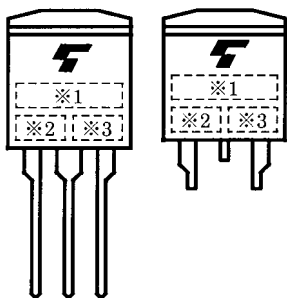


ELECTRICAL CHARACTERISTICS (Ta = 25°C)

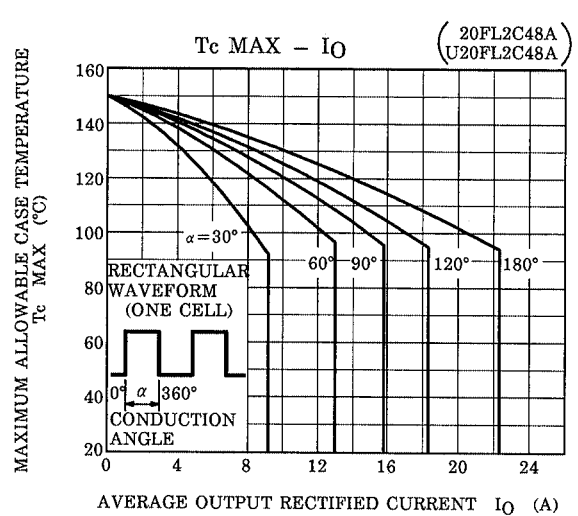
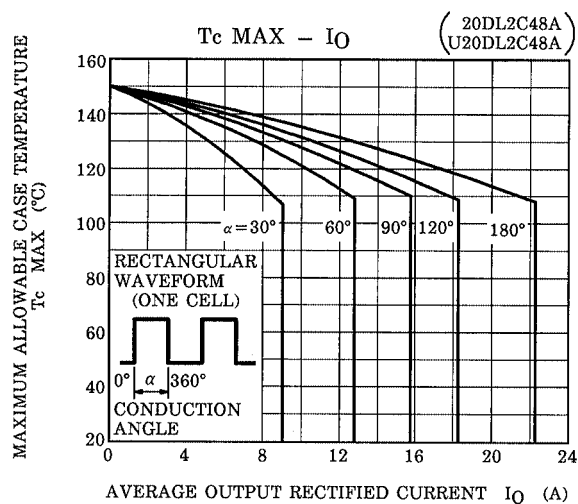
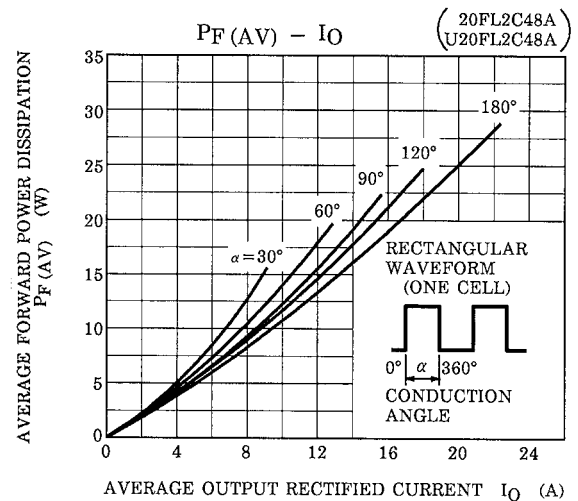
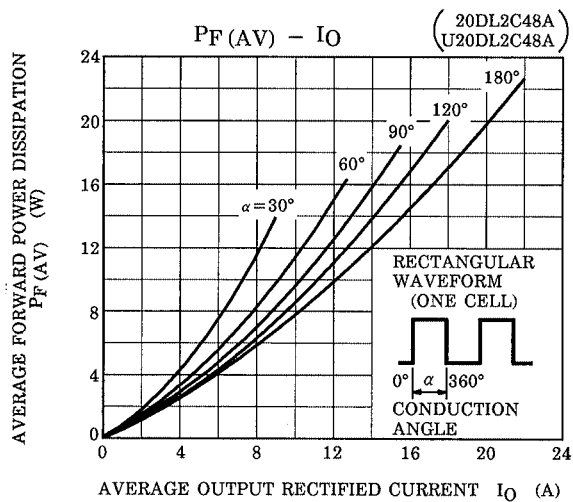
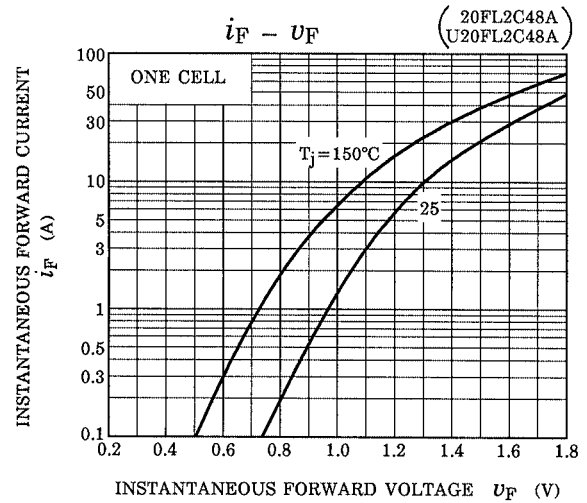
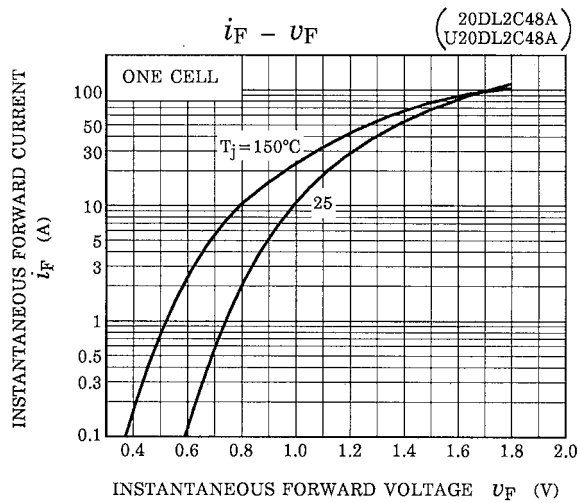
CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Peak Forward Voltage	20DL2C48A	V _{FM}	I _{FM} =10A	—	—	0.98	V
	U20DL2C48A						
	20FL2C48A						
	U20FL2C48A			—	—	1.3	
Repetitive Peak Reverse Current		I _{RRM}	V _{RRM} =Rated	—	—	50	μA
Reverse Recovery Time		t _{rr}	I _F =2A, di / dt=-50A / μs	—	—	35	ns
Forward Recovery Time		t _{fr}	I _F =1A	—	—	100	ns
Thermal Resistance		R _{th (j-c)}	DC Total	—	—	1.6	°C / W

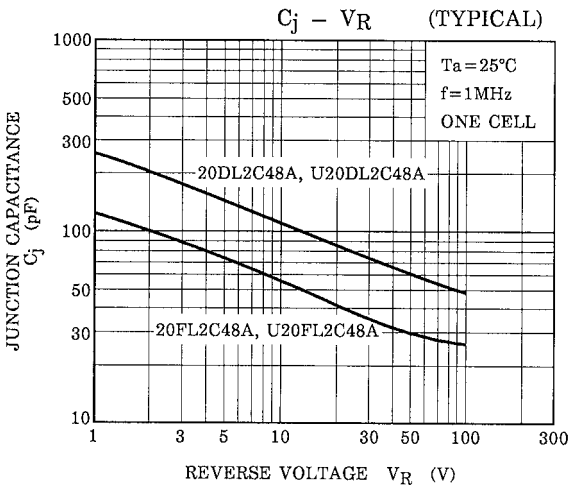
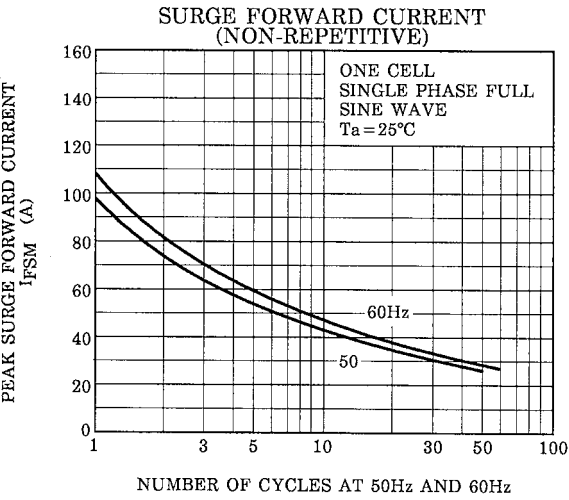
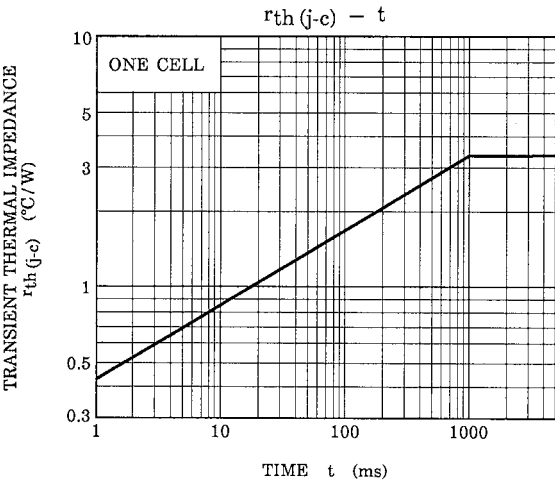
V_{FM}, I_{RRM}, t_{rr}, t_{fr} : A Value of one cell.

MARKING



* 1	MARK	20DL2C	TYPE	20DL2C48A, U20DL2C48A
		20FL2C		20FL2C48A, U20FL2C48A
* 2	A			
* 3	Lot Number □□—Month (Starting from Alphabet A) └───Year (Last Number of the Cristian Era)			





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000707EAA

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